Se	arch No	ites	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/748,359	DUBIN ET AL.	
Examiner	Art Unit	
Tuan Quach	2826	

SEARCHED			
Class	Subclass	Date	Examiner
257	751, 758, 761-763	10/23/2005	ΤQ
(update	search)		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY	·
	DATE	EXMR